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U.S. Department of Commerce Patent and Trademark Office

Attomey's Docket No. 05918-117001

Application No. 09/808,395

n Disclosure Statement by Applicant veral sheets if necessary)

Applicant

K. Theodor Krantz et al.

Filing Date

Group Art Unit

March 14, 2001

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3.5 E. S.		U.S. Patent Documents					
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate

	Foreig	n Patent Doc	uments or P	ublished Foreign P	atent A	Application	ns	
Examiner	Desig	Document	Publication	Country or			Trans	lation
Initial	. ID	Number	Date	Patent Office	Class	Subclass	Yes	No-a
Dec.	AA	EP 0 341 993 A1	11/15/1989					
	AB	EP 0 482 749 A1	4/29/1992					
	AC	EP 0 604 731 A1	7/6/1994					
	AD	EP 0 605 013 A1	7/6/2004					-
	AE	EP 0 765 616 A1	4/2/1997			•		
	AF	EP 0 766 934 A2	9/27/1996	. \				
	AG	EP 0 780 505 A2	12/20/1996					
	АН	EP 0 826 354 A2	8/28/1997					
	AI	EP 0 937 420 A2	9/22/1999					
	AJ	GB 2 285 093 A	12/21/1994		-			
	AK	GB 2 290 052 A	6/5/1995			***************************************	1	
	AL	GB 2 296 423 B	12/28/1995					
	- AM	JP 2-191735	1/2/1990					
	AN,	JP 2 41156	29/1990					
	AO	JP 4-56008	alay ma					+
	AP-	JP 6-123061	5/9/1994					
	AQ-	Л 6-141913	51241994		/			
	AR	ЛР 6-33359	2181994		}	\		
	AS	JP 7-171011	71111995			1		1
	AT	JP 7-231842	951995					1
	- AU	JP-7-300752	11/4/1995			$\overline{}$		
	<u> </u>	JP 8-27657	1/30/1996					
	AW	ЛР 9-195153	7/29/997					
497	AX	JP 9-195154	7/29/1997					

Examiner Signature ###################################	Date Considered 4/2/05
EXAMINER: Initials citation considered. Draw line through citation if no next communication to applicant.	t in conformance and not considered. Include copy of this form with

Substitute Form PTO-1449 EModified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 05918-117001	Application No. 09/808,395		
Information Disc	Information Disclosure Statement by Applicant		Applicant K. Theodor Krantz et al.		
7 (Use several st	(Use several sheets if necessary) B(b))	Filing Date March 14, 2001	Group Art Unit 1771		
	tont Documents or Bul				

3.	UENBER	Foreig	n Patent Doc	uments or P	ublished Foreign P	atent /	Application	ns	
	Examiner	Desig	Document	Publication	Country or				lation
	Initial	. ID	Number	Date	Patent Office	Class	Subclass	Yes	'No.
1	#C	AY	JP 9-195155	7/29/1997	\	<u> </u>		\	
\dashv		AZ	JP 9-309168	12/2/1997	_			1	
4		AAA	JP 10-146207	1d 2/1998				+-	
+		ABB	JP 10-151005	691918				+	
╬		ACC	ЛР 10-165207	6/23/1998				+	
Ī		ADD	WO 92/01401	7/16/1991					
ſ		AEE	WO 95/05140	2/23/1995					
Ī		AFF	WO 95/17111	6/29/1995					\
		AGG	WO 95/33390	12/14/1995					
		АНН	WO 96/03101	281996	· · · · · · · · · · · · · · · · · · ·		ı		
		AII	WO 96/14459	5/17/1996		7			
	•	AJJ	.WO 96/19960	7/4/1996					\top
		AKK	WO 98/33410	861998					$\neg \top$
		ALL	WO 99/17631	3/14/1995					$\neg \forall$
	SC.	AMM	WO 99/48455	9/30/1999					/

(Other Documents (include Author, Title, Date, and Place of Publication)						
Examiner Initial	Desig. ID	Document					
	, ANN						
	[′] A00						
	APP						
	AQQ						

Examiner Signature HWWW	Date Considered 41 2105
EXAMINER: Initials citation considered. Draw line through citation next communication to applicant.	if not in conformance and not considered. Include copy of this form with

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 05918-117001	Application No. 09/808,395
	closure Statemark E	Applicant K. Theodor Krantz et	al.
(Use several s		Filing Date	Group Art Unit
(37 CFR §1.98(b))	F HON O	March 14, 2001	1771

			रेग्रा,S. Pate	nt Documents			
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
AC.	AA	5,749,129	05/12/1998	Murasaki et al.			
	AB						
	AC						
	AD						
	AE						
	AF						-
	AG						
	AH						
	AI					-	
	AJ					~	
	AK					, i	

	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.	Document	Publication	Country or			Trans	slation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
Ste	AL	CN 1153701A	96/11/5	China				х
	AM							
	AN							
	AO							
	AP							

	Other Documents (include Author, Title, Date, and Place of Publication)						
Examiner Initial	Desig. ID	Document					
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	AR						
	AS						
	AT						

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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with	
next communication to applicant	